

<b>Notice of References Cited</b>	Application/Control No. 10/566,507	Applicant(s)/Patent Under Reexamination VERSTEGEN ET AL.	
	Examiner HENOK G. HEYI	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,510,163 A	04-1996	Sullivan et al.	428/64.1
*	B	US-5,840,395 A	11-1998	Sawada et al.	428/64.1
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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